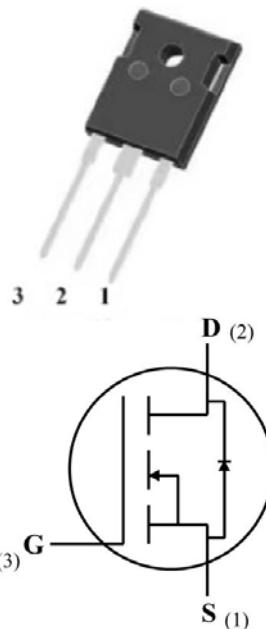


Silicon Carbide Power MOSFET (N-Channel Enhancement)

V _{DS}	1200V
I _{D (25°C)}	38A
R _{DS(on)}	80mΩ



Features

- High speed switching
- Essentially no switching losses
- Reduction of heat sink requirements
- Maximum working temperature at 175 °C
- High blocking voltage
- Fast Intrinsic diode with low recovery current
- High-frequency operation
- Halogen free, RoHS compliant
- AEC-Q101 qualified

Typical Applications

Typical applications are in power factor correction(PFC), solar inverter, uninterruptible power supply, motor drives, photovoltaic inverter, electric car and charger.

Mechanical Data

- **Package:** TO-247AB
- **Terminals:** Tin plated leads
- **Polarity:** As marked

■Maximum Ratings (T_C=25°C Unless otherwise specified)

PARAMETER	SYMBOL	UNIT	VALUE	TEST CONDITIONS	NOTE
Device marking code				D212080NCTG1	
Drain source voltage @ T _j =25°C	V _{DS,max}	V	1200	V _{GS} =0 V, I _D =100uA	
Gate source voltage @ T _j =25°C	V _{GS,max}	V	-8/+22	Absolute maximum values	Note1
Gate source voltage @ T _j =25°C	V _{GS,op}	V	-4/+18	Recommended operational values	Note2
Continuous drain current @ T _c =25°C	I _D	A	38	V _{GS} =18V, T _c =25°C	Fig.18
Continuous drain current @ T _c =100°C			28	V _{GS} =18V, T _c =100°C	
Pulsed drain current	I _{D(pulsed)}	A	80	Pulse width t _p limited by T _{j,max}	Fig.23
Power Dissipation	P _{TOT}	W	214	T _c =25°C , T _j = 175°C	Fig.17
Power Dissipation			94	T _c =110°C, T _j = 175°C	
Operating junction and Storage temperature range	T _j , T _{stg}	°C	-55 to +175		
Soldering temperature	T _L	°C	260	1.6mm (0.063") from case for 10s	
Mounting torque	T _M	Nm	0.6	M3 screw Maximum of mounting process: 3	



■ Static Electrical Characteristics (Tc=25°C unless otherwise specified)

PARAMETER	SYMBOL	UNIT	Min.	Typ.	Max.	Test Conditions	Note
Gate threshold voltage	V _{GS(th)}	V	2.3	2.9	3.6	V _{DS} =V _{GS} , I _D =5mA	Fig.4, 11
				2.2		V _{DS} =V _{GS} , I _D =5mA, T _j =175°C	
Drain source breakdown voltage	V _{(BR)DSS}	V	1200			V _{GS} =0, I _D =100uA	
Zero gate voltage drain current	I _{DSS}	uA		1	10	V _{DS} =1200V, V _{GS} =0V	Fig.16
Gate source leakage current	I _{GSS}	nA			100	V _{GS} =18V, V _{DS} =0V	
Current drain source on-state resistance	R _{DS ON}	mΩ		77	85	V _{GS} =18V, I _D =20A	Fig.5, 6, 7
				122		V _{GS} =18V, I _D =20A, T _j =175°C	
Internal gate resistance	R _g	Ω		1.5		f=1MHz	
Diode forward voltage	V _{SD}	V		3.9		V _{GS} =-4V, I _{SD} =10A	Fig.8
				3.2		V _{GS} =0V, I _{SD} =10A T _j =175°C	Fig.9
Transconductance	g _f	S		10		V _{DS} =16V, I _D =20A	Fig.4
				9.2		V _{DS} =16V, I _D =20A, T _j =175°C	

■ Dynamic Electrical Characteristics (Tc=25°C unless otherwise specified)

PARAMETER	SYMBOL	UNIT	Min.	Typ.	Max.	Test Conditions	Note
Input capacitance	C _{iss}	pF		890		V _{DS} =1000V, V _{GS} =0V, T _j =25°C, f=1MHz, V _{AC} =25mV	Fig.13, 14
Output capacitance	C _{oss}			58			
Reverse capacitance	C _{rss}			4			
C _{oss} stored energy	E _{oss}	uJ		34		V _{DS} =800V, V _{GS} =-4/18V, I _D =20A	Fig.15
Gate source charge	Q _{gs}	nC		12			Fig.12
Gate drain charge	Q _{gd}			11			
Gate charge	Q _g			41			

■ Switching Characteristics (Tc=25°C unless otherwise specified)

PARAMETER	SYMBOL	UNIT	Min.	Typ.	Max.	Test Conditions	Note
Turn on switching energy	E _{on}	uJ		320		V _{DD} =800V, V _{GS} =-4/+18V, I _D =20A, R _g =0Ω, L=120uH	Fig.21, 22
Turn off switching energy	E _{off}			49			
Turn on delay time	t _{d(on)}	ns		19			
Rise time	t _r			21			



Turn off delay time	$t_{d(\text{off})}$	ns	15		$V_{DD}=800V, V_{GS}=-4/+18V, I_D=20A, R_g=0\Omega, L=220\mu H$	Fig.21, 22
Fall time	t_f		17			

■Body diode characteristics (Tc=25°C unless otherwise specified)

PARAMETER	SYMBOL	UNIT	Min.	Typ.	Max.	Test Conditions	Note
Diode forward voltage	V_{SD}	V		3.9		$V_{GS}=-4V, I_{SD}=10A$	Fig.8
				3.2		$V_{GS}=0V, I_{SD}=10A, T_j=175^{\circ}C$	Fig.9
Continuous diode forward current	I_s	A		38		$T_c=25^{\circ}C$	Note1
Reverse recovery time	t_{rr}	nS		41		$V_R=800V, V_{GS}=-4V, I_D=20A, dI/dt=700A/\mu s$	
Reverse recovery charge	Q_{rr}	nC		405			
Peak reverse recovery current	I_{rrm}	A		20			

Note 1: When using SiC Body Diode the maximum recommended $V_{GS} = -4V$

Note 2: MOSFET can also safely operate at 0/18 V

■Thermal Characteristics (Ta=25°C Unless otherwise specified)

PARAMETER	SYMBOL	UNIT	Value
Thermal resistance	$R_{\theta J-C}$	°C/W	0.7

■Typical Characteristics

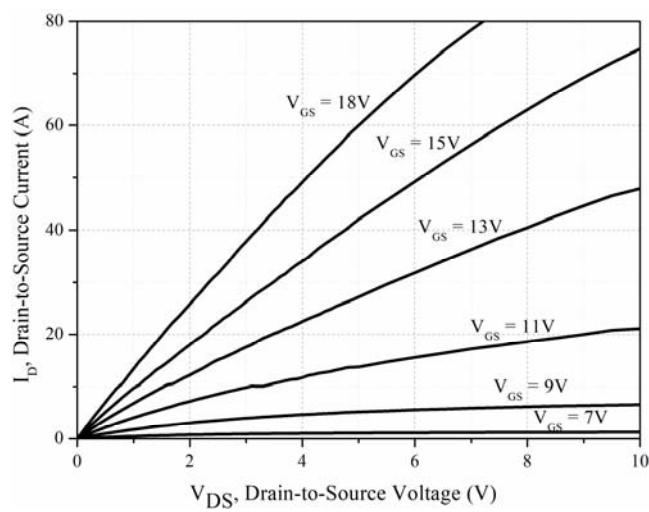


Figure 1. Output Characteristics $T_j = -40^{\circ}C$

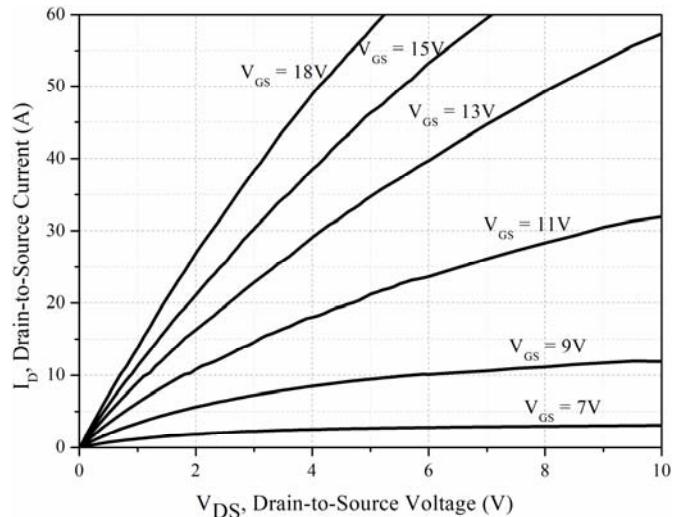


Figure 2. Output Characteristics $T_j = 25^{\circ}C$

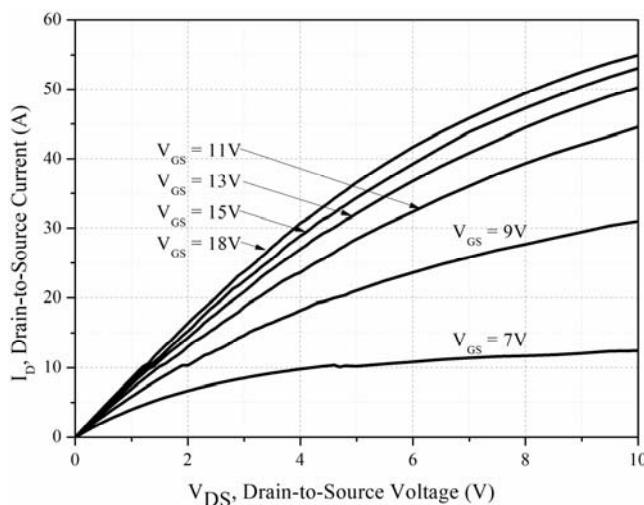


Figure 3. Output Characteristics $T_j = 175^\circ\text{C}$

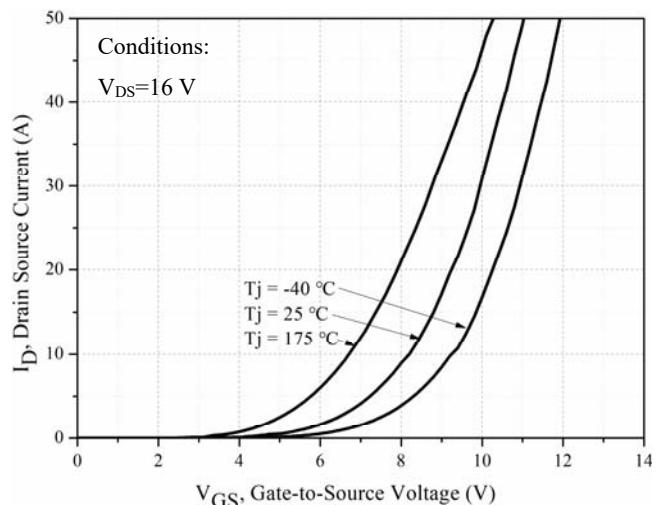


Figure 4. Transfer Characteristics for various junction temperature

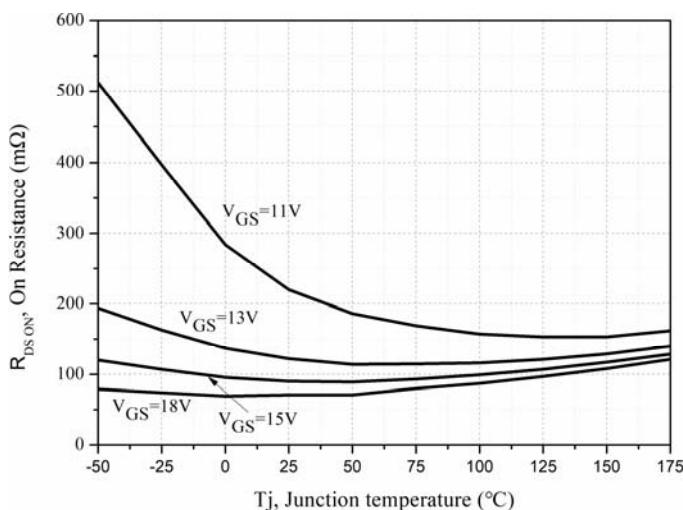


Figure 5. On-resistance vs. temperature for various gate voltage

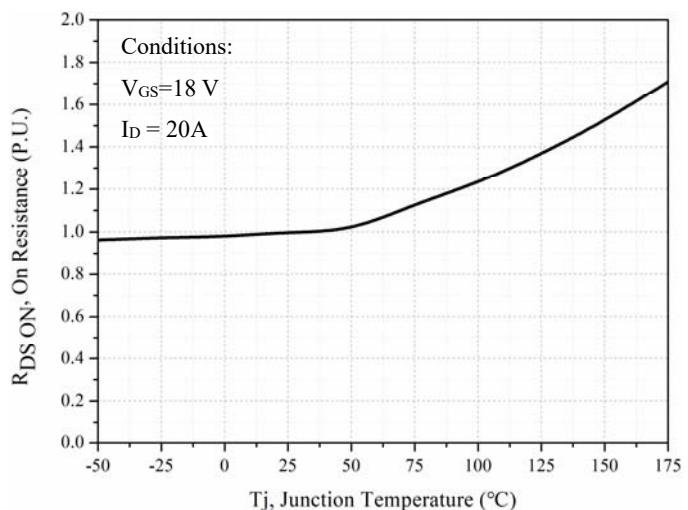


Figure 6. Normalized on-resistance vs. temperature

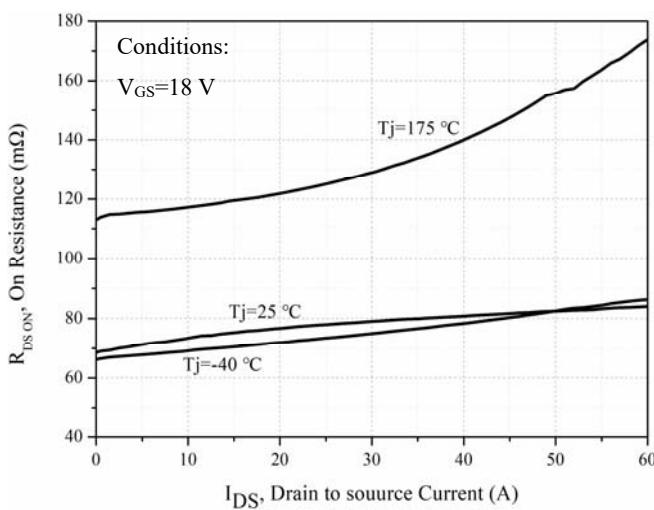


Figure 7. On-resistance vs. drain current

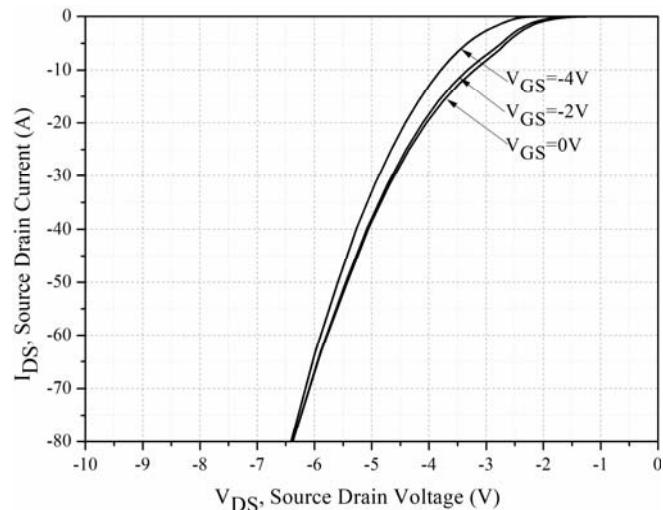


Figure 8. Body diode characteristic at $T_j = 25^\circ\text{C}$

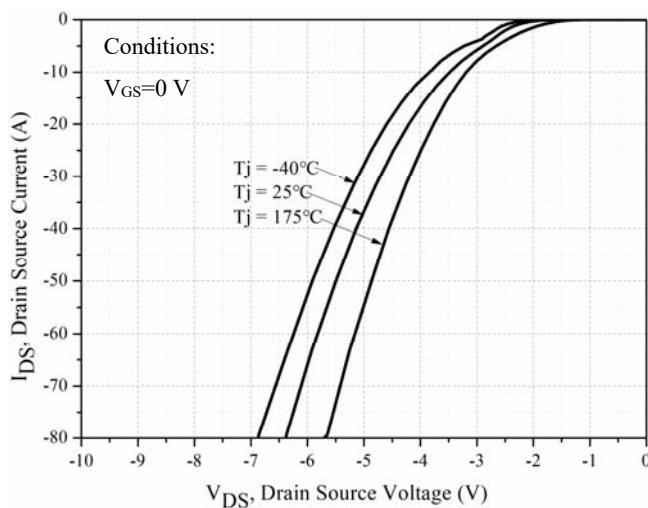


Figure 9. Body diode characteristic

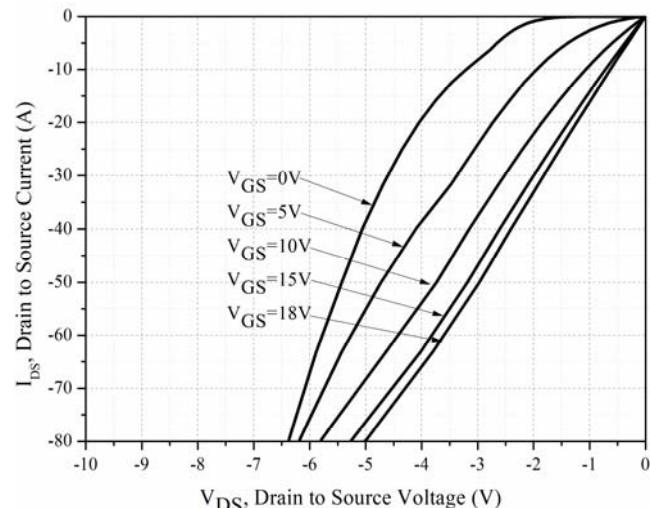


Figure 10. 3rd quadrant characteristic at $T_j = 25^\circ\text{ C}$

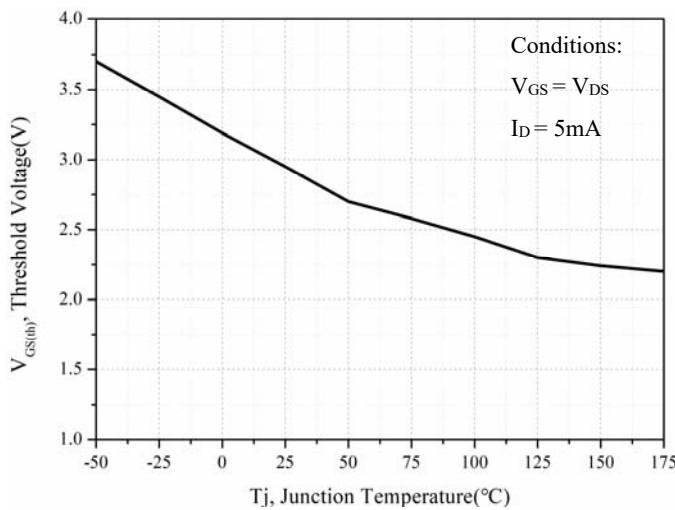


Figure 11. Threshold voltage vs. temperature

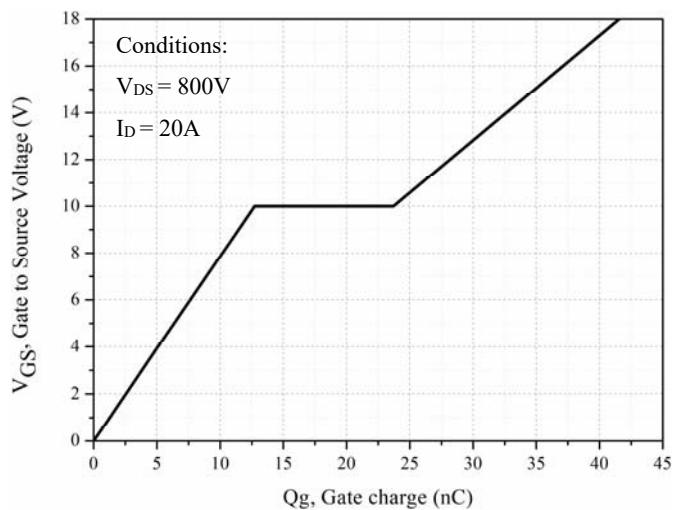


Figure 12. Gate charge characteristic

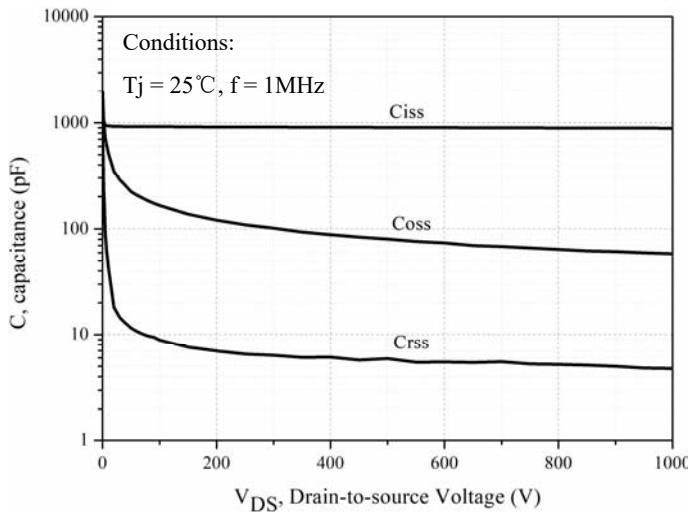


Figure 13. Capacitances vs. drain source voltage (0-1000V)

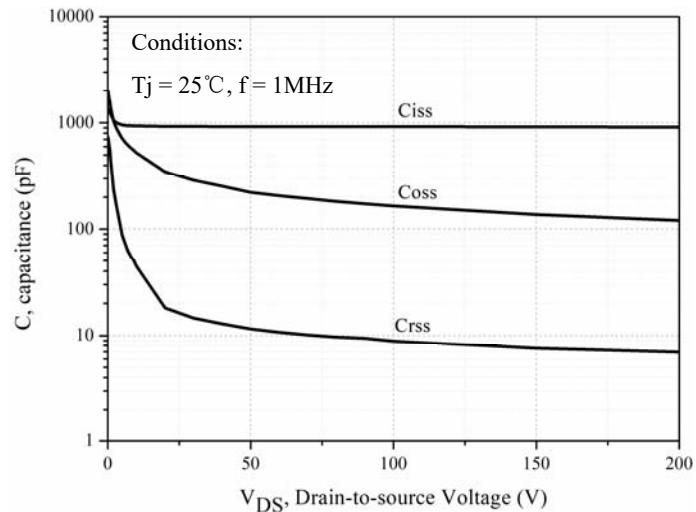
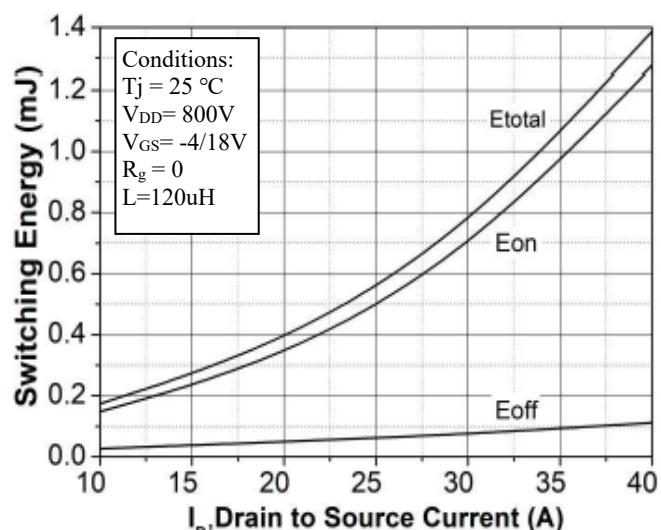
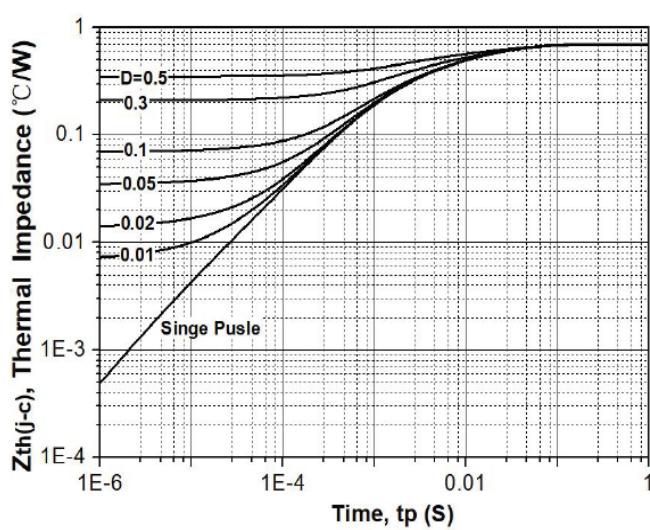
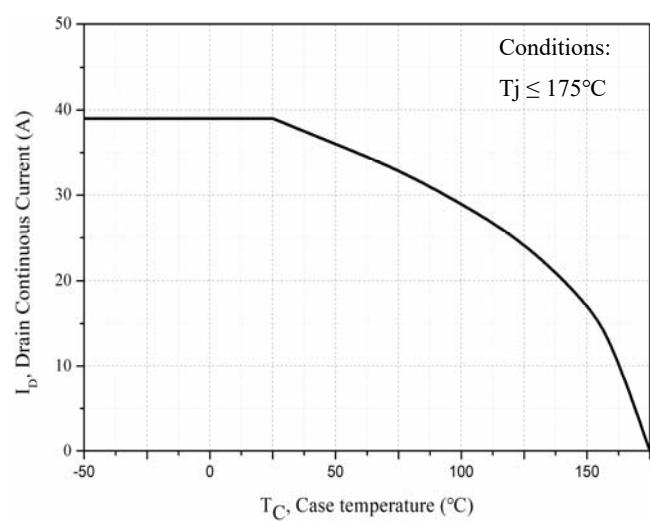
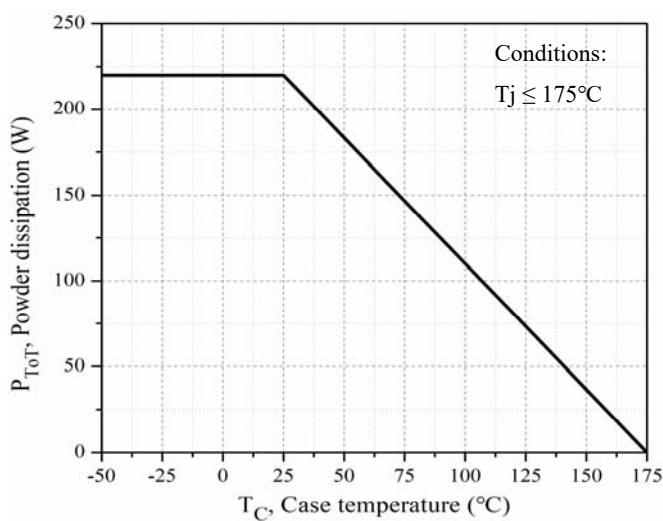
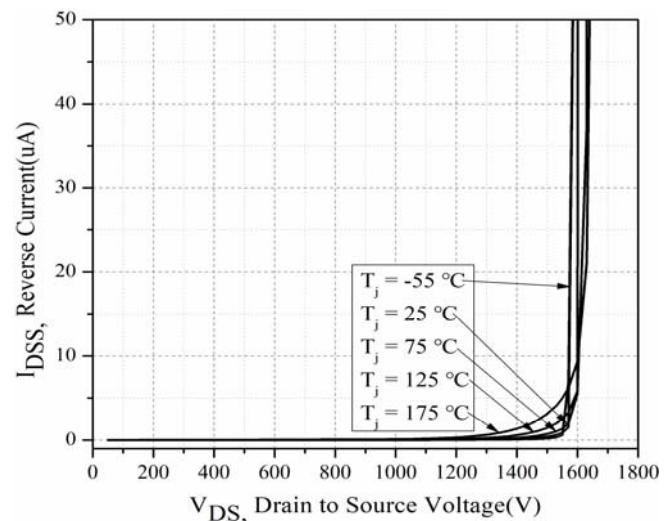
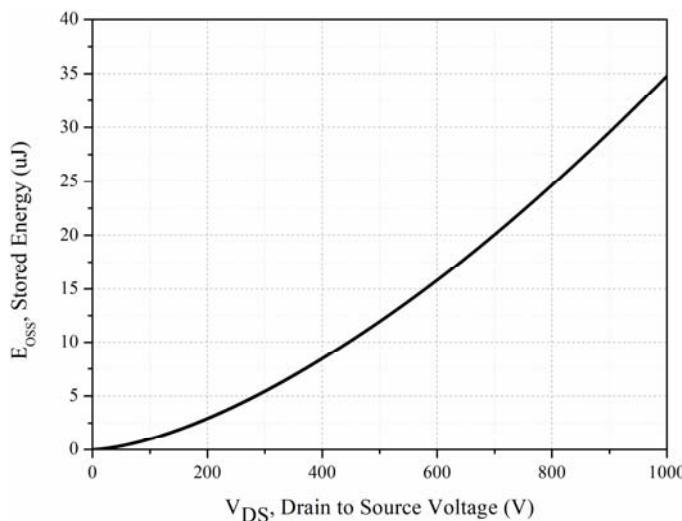


Figure 14. Capacitances vs. drain source voltage (0-200V)



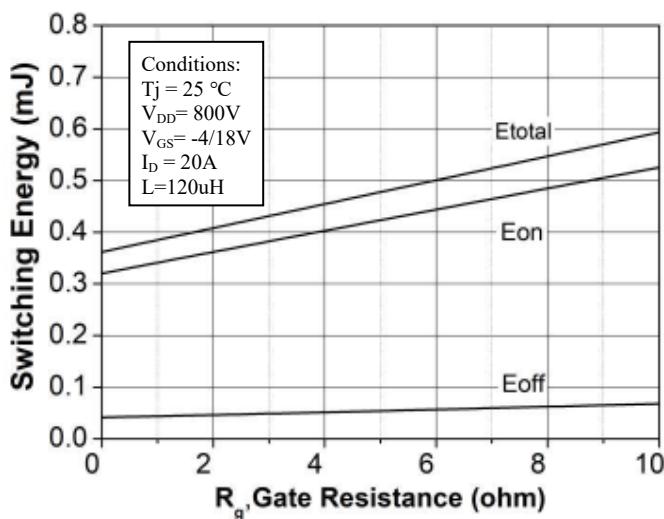


Figure 21. Clamped inductive switching energy vs. R_g

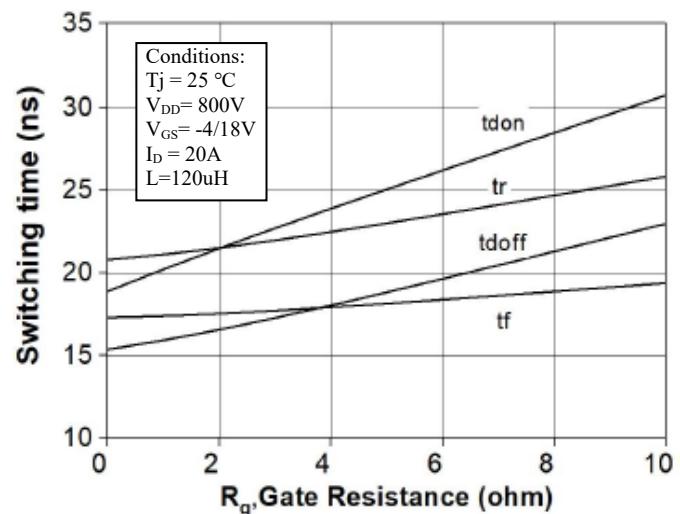


Figure 22. Switching times vs. R_g

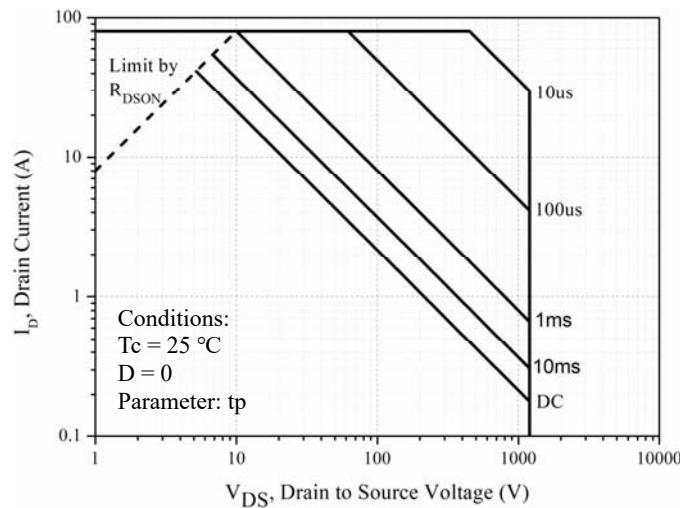


Figure 23. Safe operating area

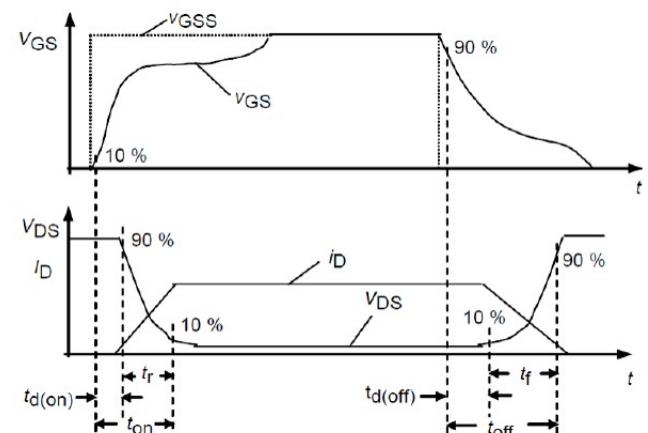


Figure 24. Switching Times Definition

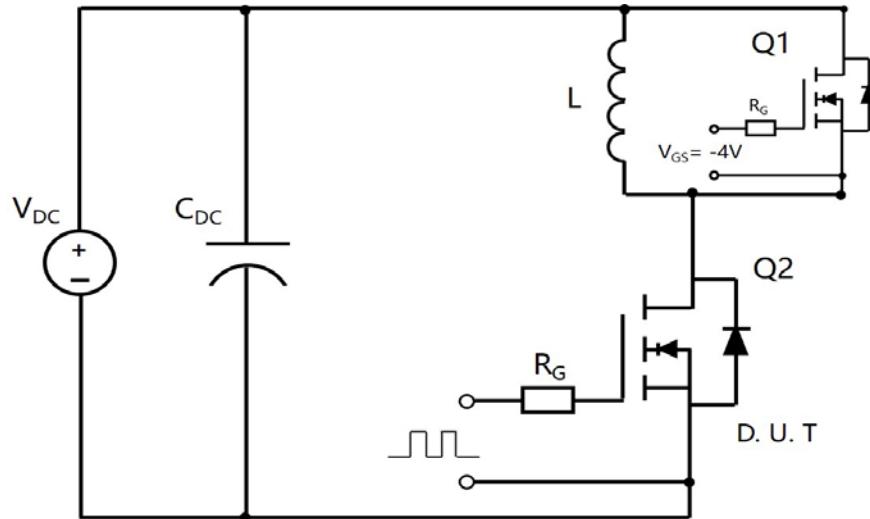
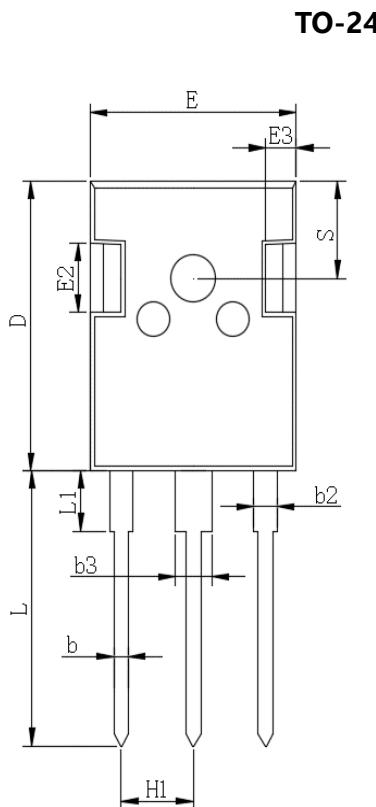


Figure 25. Clamped Inductive Switching Waveform Test Circuit

■Outline Dimensions



TO-247AB		
Dim	Min	Max
A	4.80	5.20
A1	2.21	2.61
A2	1.85	2.15
b	1.0	1.4
b2	1.91	2.21
C	0.5	0.7
D	20.70	21.30
D1	16.25	16.85
E	15.50	16.10
E1	13.0	13.6
E2	4.80	5.20
E3	2.30	2.70
L	19.62	20.22
L1	-	4.30
ΦP	3.40	3.80
ΦP1	-	7.30
S	6.15TYP	
H1	5.44TYP	
b3	2.80	3.20



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